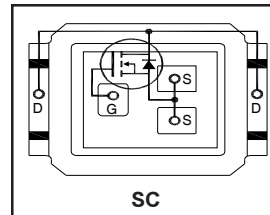


DirectFET® Power MOSFET ②

- Advanced Process Technology
- Optimized for Automotive DC-DC, Motor Drive and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- Lead free, RoHS and Halogen free

$V_{(BR)DSS}$	<b>40V</b>
$R_{DS(on)}$ typ.	<b>5.5mΩ</b>
max.	<b>6.95mΩ</b>
$I_D$ (Silicon Limited)	<b>55A</b>
$Q_g$	<b>30nC</b>



Applicable DirectFET Outline and Substrate Outline ①

<b>SB</b>	<b>SC</b>			<b>M2</b>	<b>M4</b>		<b>L4</b>	<b>L6</b>	<b>L8</b>	
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### Description

The AUIRF7732S2 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve low gate charge as well as the lowest on-state resistance in a package that has the footprint which is 38% smaller than an SO-8 and only 0.7mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are of value. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRF7732S2 to offer substantial system level savings and performance improvement specifically in high frequency DC-DC, motor drive and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low  $Q_g$  per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

### Ordering Information

Base Part Number	Package Type	Standard Pack		Complete part Number
		Form	Quantity	
AUIRF7732S2	DirectFET2 Small -Can	Tape and Reel	4800	AUIRF7732S2TR
AUIRF7732S2	DirectFET2 Small -Can	Tape and Reel Option 1	1000	AUIRF7732S2TR1

### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature ( $T_A$ ) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
$V_{DS}$	Drain-to-Source Voltage	40	V
$V_{GS}$	Gate-to-Source Voltage	± 20	
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)④	55	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)④	39	
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)③	14	
$I_{DM}$	Pulsed Drain Current ⑦	220	
$P_D @ T_C = 25^\circ C$	Power Dissipation ④	41	W
$P_D @ T_A = 25^\circ C$	Power Dissipation ③	2.5	
$E_{AS}$	Single Pulse Avalanche Energy (Thermally Limited) ⑥	45	mJ
$E_{AS}$ (tested)	Single Pulse Avalanche Energy Tested Value ⑥	100	
$I_{AR}$	Avalanche Current ⑤	See Fig. 18a,18b,16,17	A
$E_{AR}$	Repetitive Avalanche Energy ⑤		mJ
$T_P$	Peak Soldering Temperature	260	
$T_J$	Operating Junction and	-55 to + 175	°C
$T_{STG}$	Storage Temperature Range		

HEXFET® is a registered trademark of International Rectifier.

**Static Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	40	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
ΔV <sub>(BR)DSS/ΔT<sub>J</sub></sub>	Breakdown Voltage Temp. Coefficient	—	0.03	—	V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance	—	5.5	6.95	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 33A ②
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	—	4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 50μA
ΔV <sub>GS(th)/ΔT<sub>J</sub></sub>	Gate Threshold Voltage Coefficient	—	-8.1	—	mV/°C	
g <sub>fs</sub>	Forward Transconductance	52	—	—	S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 33A
R <sub>G</sub>	Gate Resistance	—	0.7	—	Ω	
I <sub>DSS</sub>	Drain-to-Source Leakage Current	—	—	5	μA	V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V
		—	—	250		V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	—	—	100	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage	—	—	-100		V <sub>GS</sub> = -20V

**Dynamic Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge	—	30	45	nC	V <sub>DS</sub> = 20V V <sub>GS</sub> = 10V I <sub>D</sub> = 33A See Fig.11
Q <sub>gs1</sub>	Pre-V <sub>th</sub> Gate-to-Source Charge	—	5.1	—		
Q <sub>gs2</sub>	Post-V <sub>th</sub> Gate-to-Source Charge	—	2.8	—		
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge	—	9.7	—		
Q <sub>godr</sub>	Gate Charge Overdrive	—	12	—		
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )	—	12.5	—	nC	V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V
Q <sub>oss</sub>	Output Charge	—	16	—		
t <sub>d(on)</sub>	Turn-On Delay Time	—	9.6	—	ns	V <sub>DD</sub> = 20V, V <sub>GS</sub> = 4.5V ② I <sub>D</sub> = 33A R <sub>G</sub> = 6.8Ω
t <sub>r</sub>	Rise Time	—	25	—		
t <sub>d(off)</sub>	Turn-Off Delay Time	—	24	—		
t <sub>f</sub>	Fall Time	—	22	—	pF	V <sub>GS</sub> = 0V V <sub>DS</sub> = 25V f = 1.0MHz
C <sub>iss</sub>	Input Capacitance	—	1700	—		
C <sub>oss</sub>	Output Capacitance	—	405	—		
C <sub>rss</sub>	Reverse Transfer Capacitance	—	200	—		
C <sub>oss</sub>	Output Capacitance	—	1460	—		
C <sub>oss</sub>	Output Capacitance	—	360	—		
C <sub>oss</sub> eff.	Effective Output Capacitance	—	540	—	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 32V	

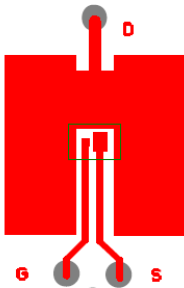
**Diode Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	55	A	MOSFET symbol showing the integral reverse p-n junction diode.
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ⑤	—	—	220		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.3	V	I <sub>S</sub> = 33A, V <sub>GS</sub> = 0V ②
t <sub>rr</sub>	Reverse Recovery Time	—	33	50	ns	I <sub>F</sub> = 33A, V <sub>DD</sub> = 20V
Q <sub>rr</sub>	Reverse Recovery Charge	—	22	33	nC	di/dt = 100A/μs ②

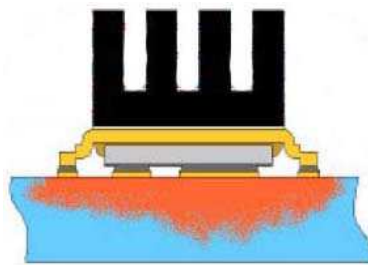


**Thermal Resistance**

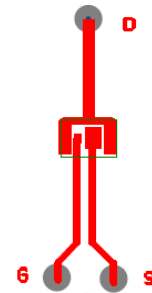
	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③	—	60	°C/W
$R_{\theta JA}$	Junction-to-Ambient ④	12.5	—	
$R_{\theta JA}$	Junction-to-Ambient ⑤	20	—	
$R_{\theta Can}$	Junction-to-Can ④⑥	—	3.7	
$R_{\theta J-PCB}$	Junction-to-PCB Mounted	1.0	—	
	Linear Derating Factor ⑦	0.27		W/°C



③ Surface mounted on 1 in. square Cu (still air).

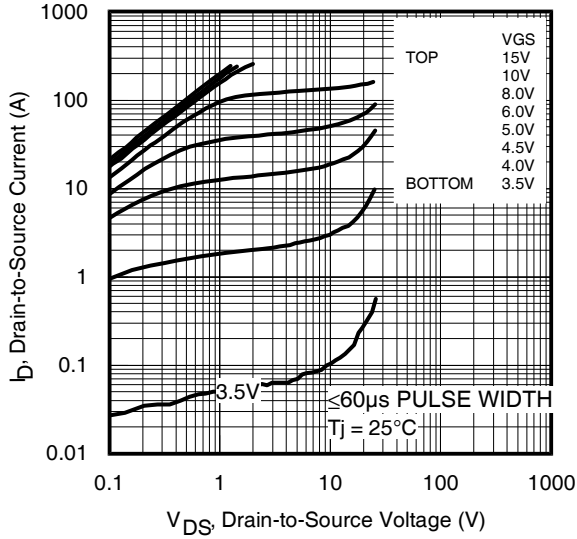
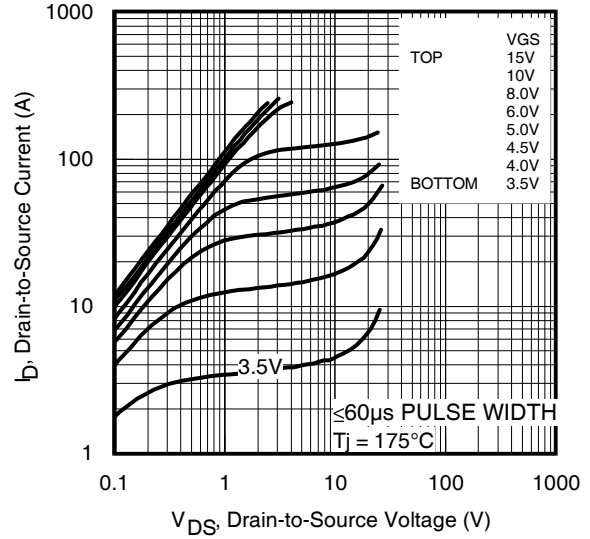
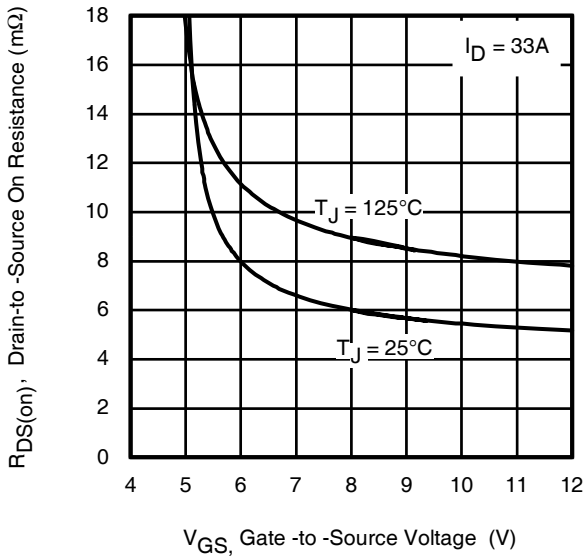
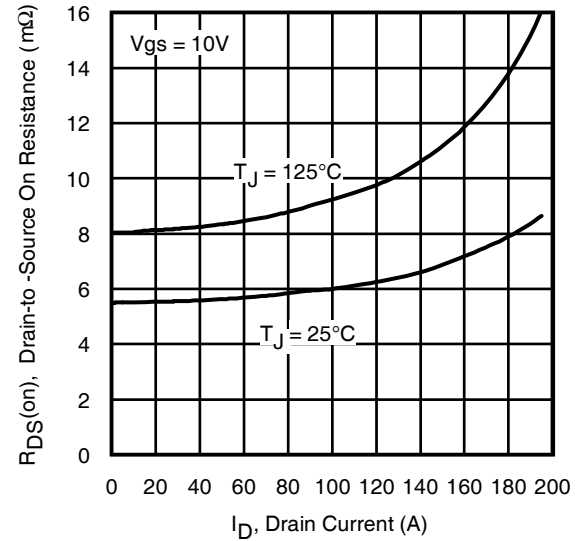
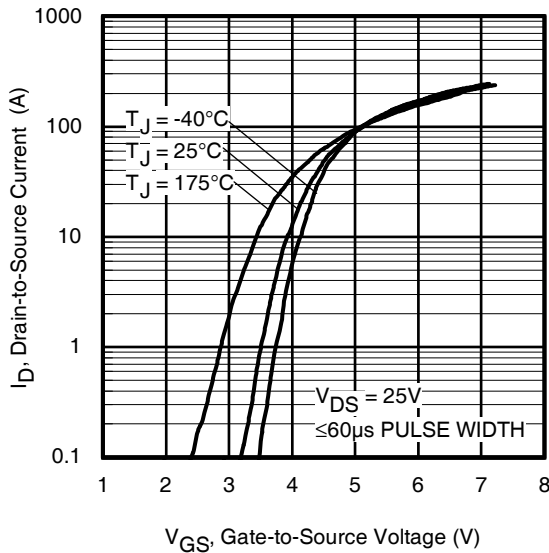
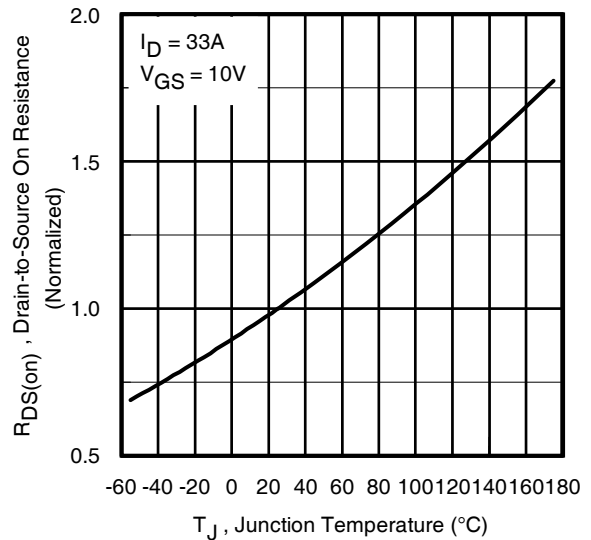


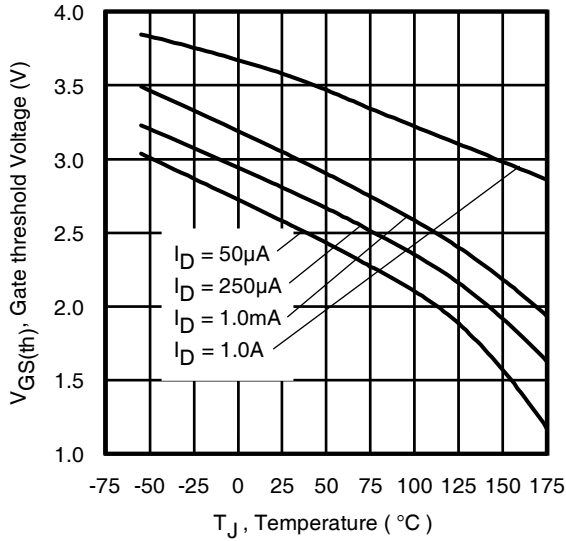
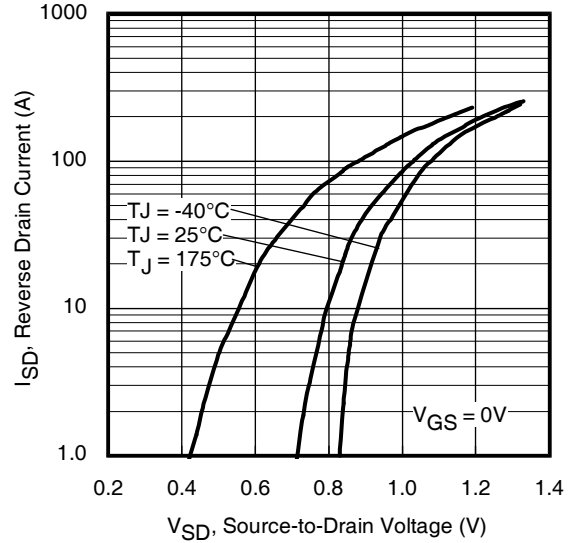
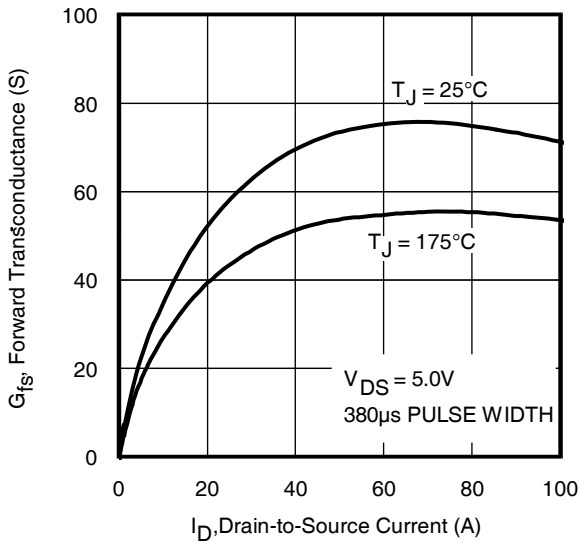
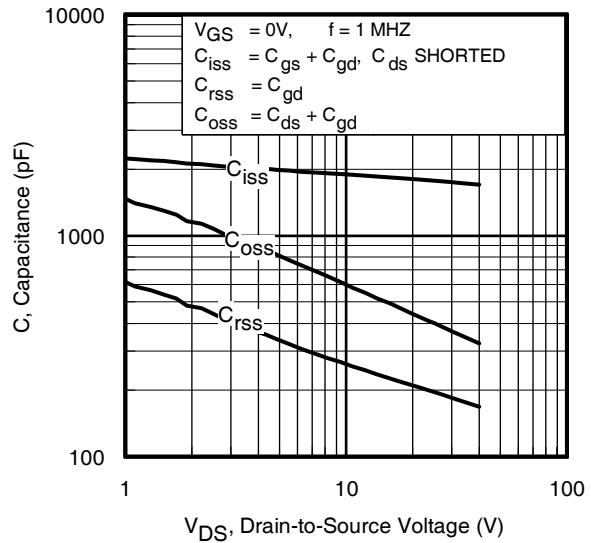
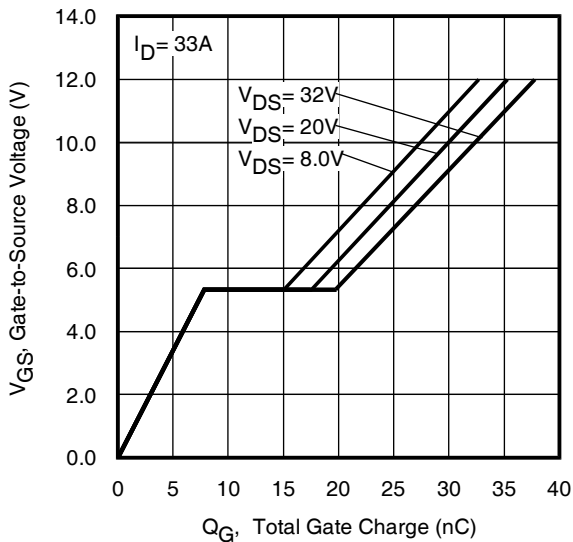
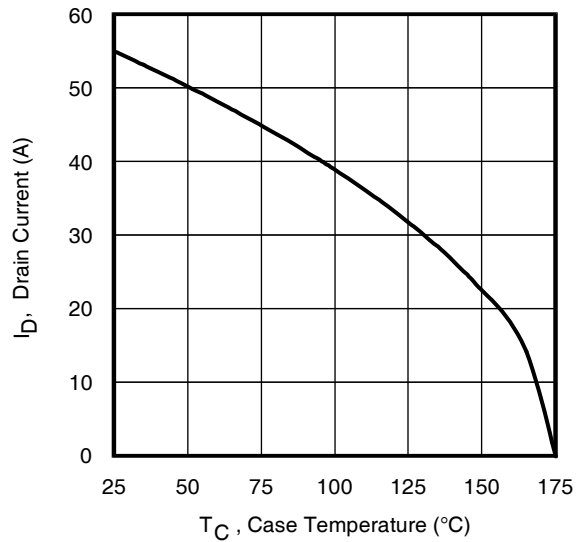
④ Mounted to a PCB with small clip heatsink (still air)

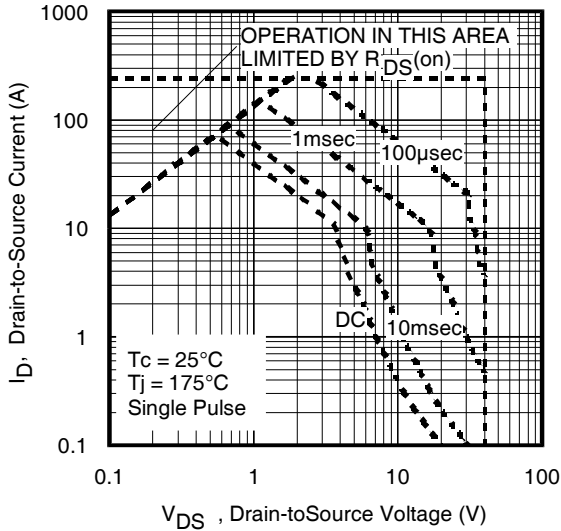
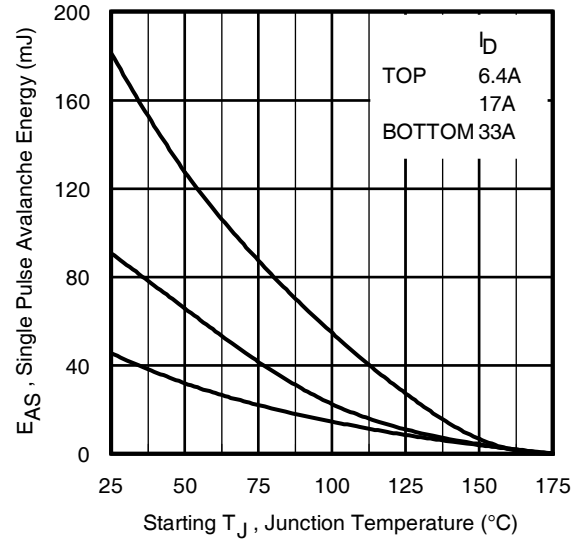
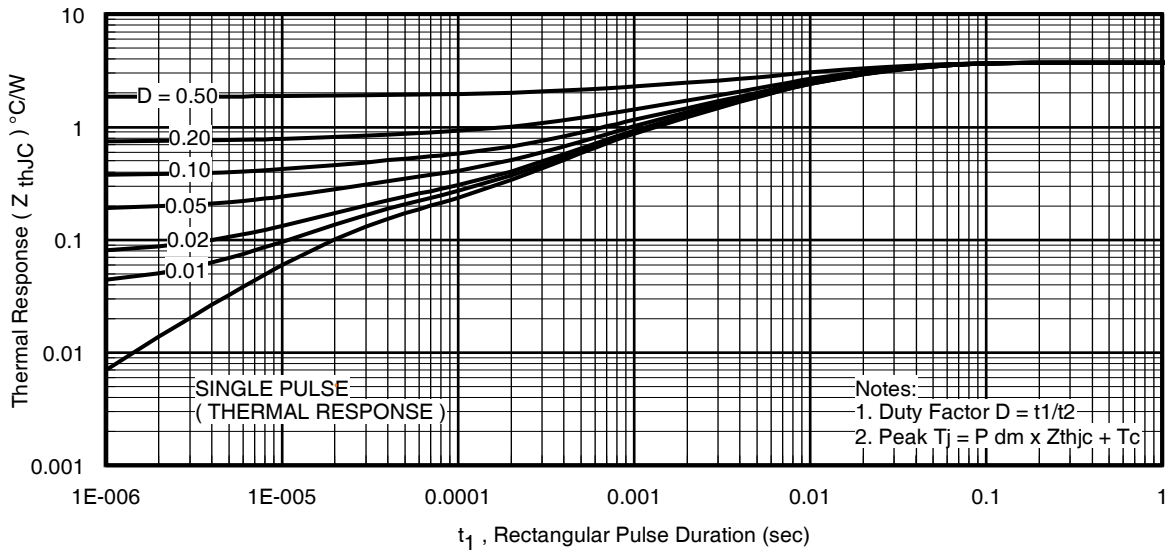
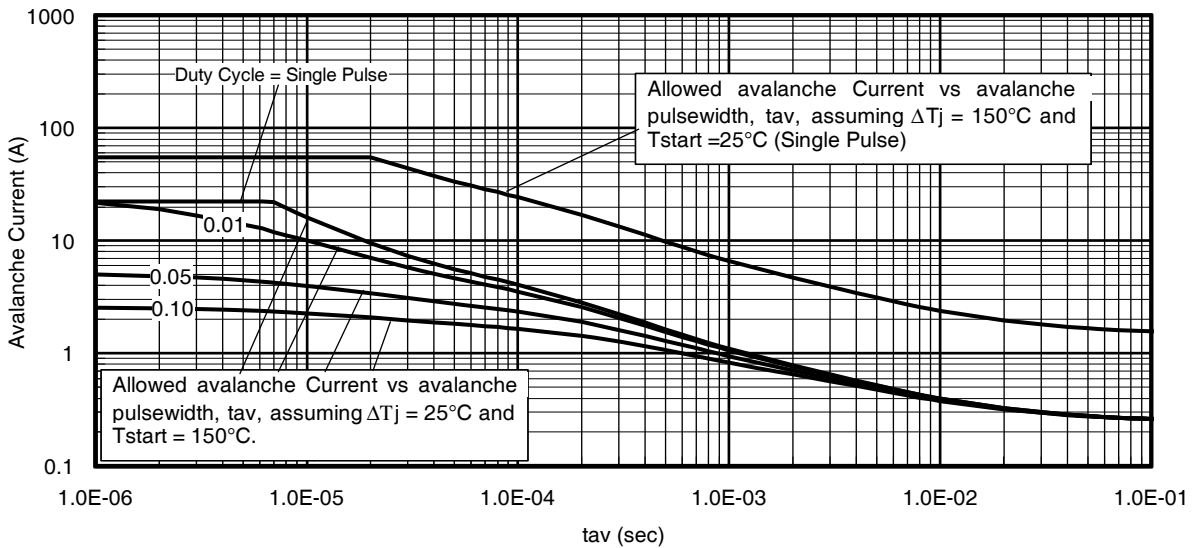


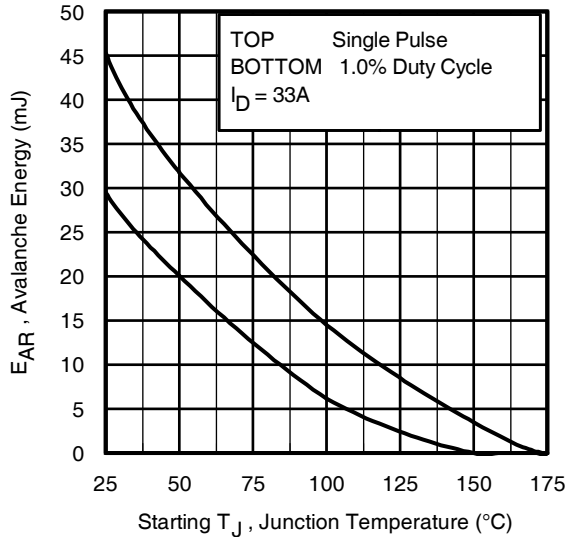
⑤ Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

Notes ① through ⑩ are on page 10


**Fig 1. Typical Output Characteristics**

**Fig 2. Typical Output Characteristics**

**Fig 3. Typical On-Resistance vs. Gate Voltage**

**Fig 4. Typical On-Resistance vs. Drain Current**

**Fig 5. Typical Transfer Characteristics**

**Fig 6. Normalized On-Resistance vs. Temperature**


**Fig 7.** Typical Threshold Voltage vs. Junction Temperature

**Fig 8.** Typical Source-Drain Diode Forward Voltage

**Fig 9.** Typical Forward Transconductance vs. Drain Current

**Fig 10.** Typical Capacitance vs. Drain-to-Source Voltage

**Fig.11** Typical Gate Charge vs. Gate-to-Source Voltage

**Fig 12.** Maximum Drain Current vs. Case Temperature


**Fig 13. Maximum Safe Operating Area**

**Fig 14. Maximum Avalanche Energy vs. Temperature**

**Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case**

**Fig 16. Typical Avalanche Current vs. Pulsewidth**



**Fig 17.** Maximum Avalanche Energy vs. Temperature

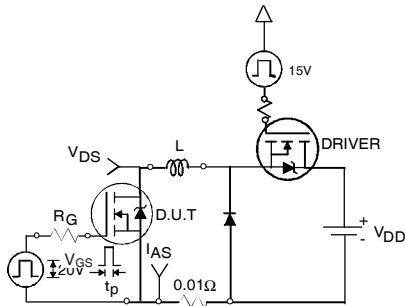
**Notes on Repetitive Avalanche Curves , Figures 16, 17:**  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5.  $BV$  = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 16, 17).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 15)

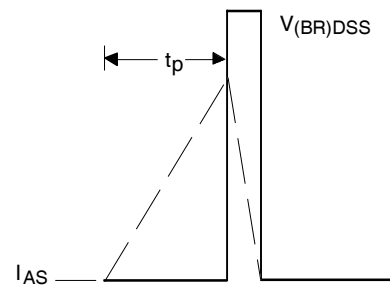
$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [ 1.3 \cdot BV \cdot Z_{th} ]$$

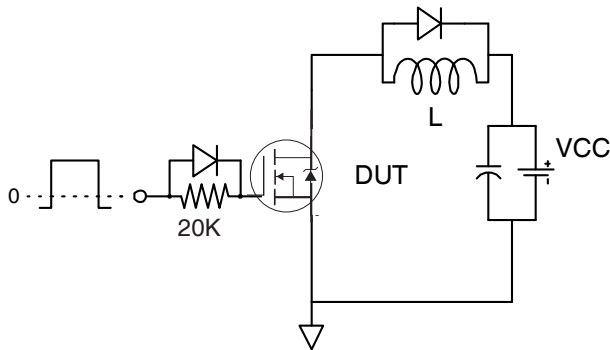
$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$



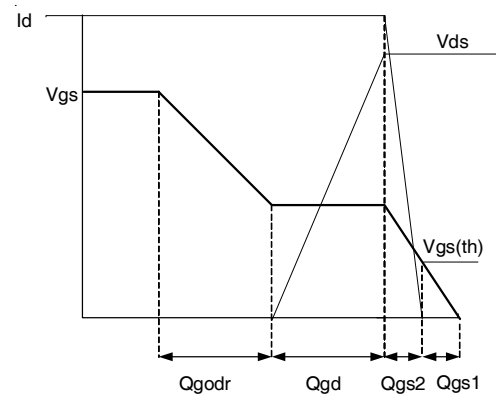
**Fig 18a.** Unclamped Inductive Test Circuit



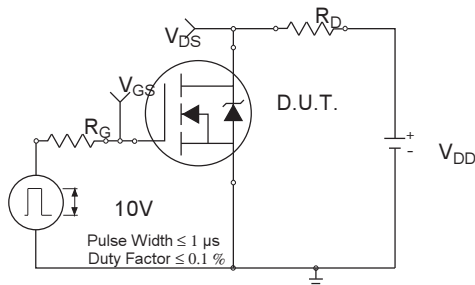
**Fig 18b.** Unclamped Inductive Waveforms



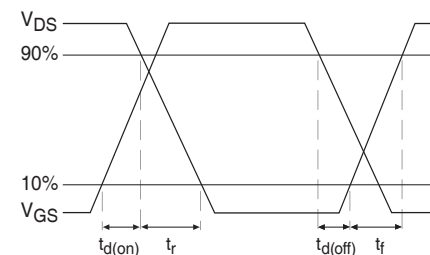
**Fig 19a.** Gate Charge Test Circuit



**Fig 19b.** Gate Charge Waveform



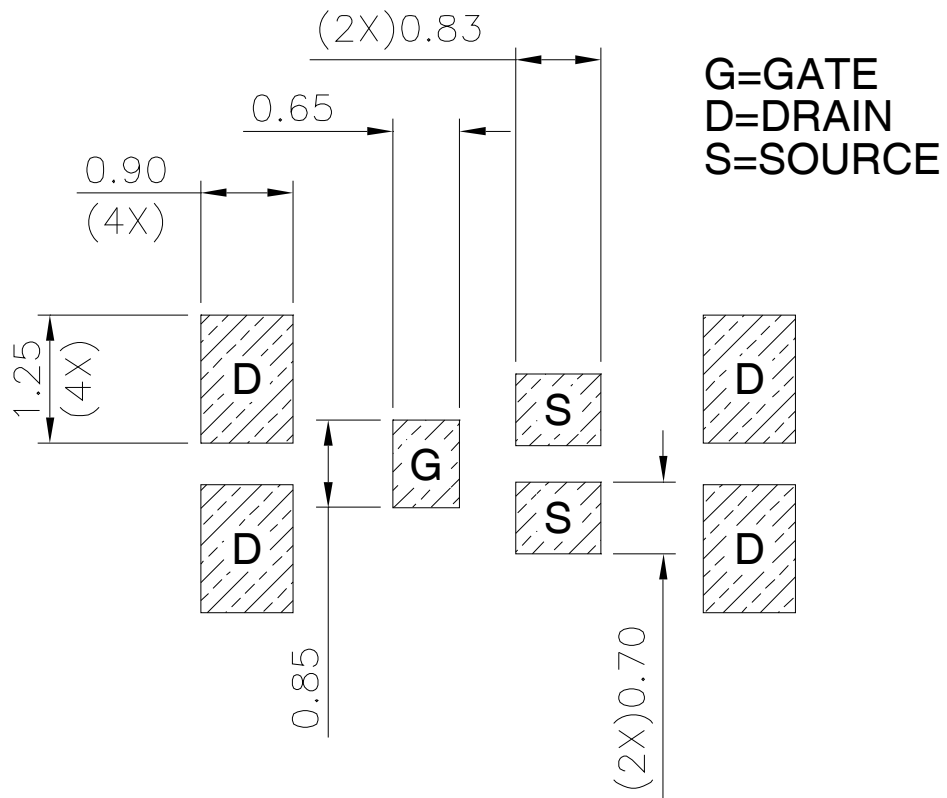
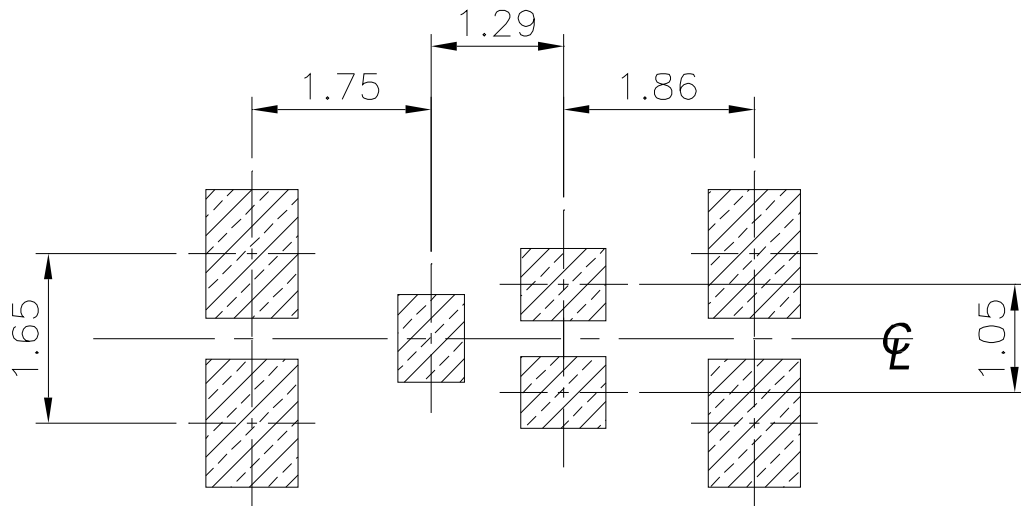
**Fig 20a.** Switching Time Test Circuit



**Fig 20b.** Switching Time Waveforms

**Automotive DirectFET® Board Footprint, SC (Small Size Can).**

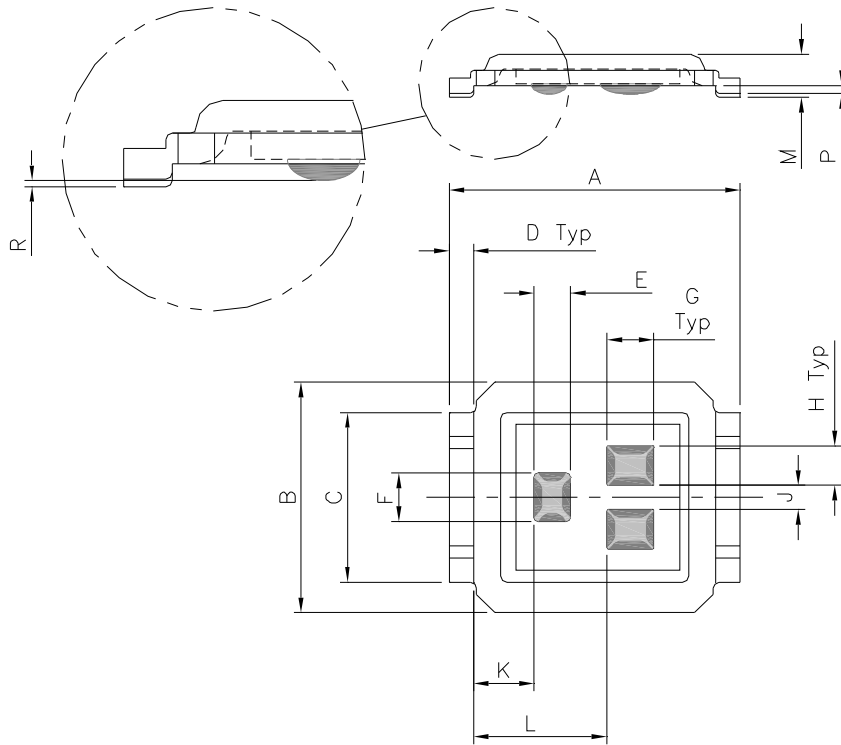
Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations





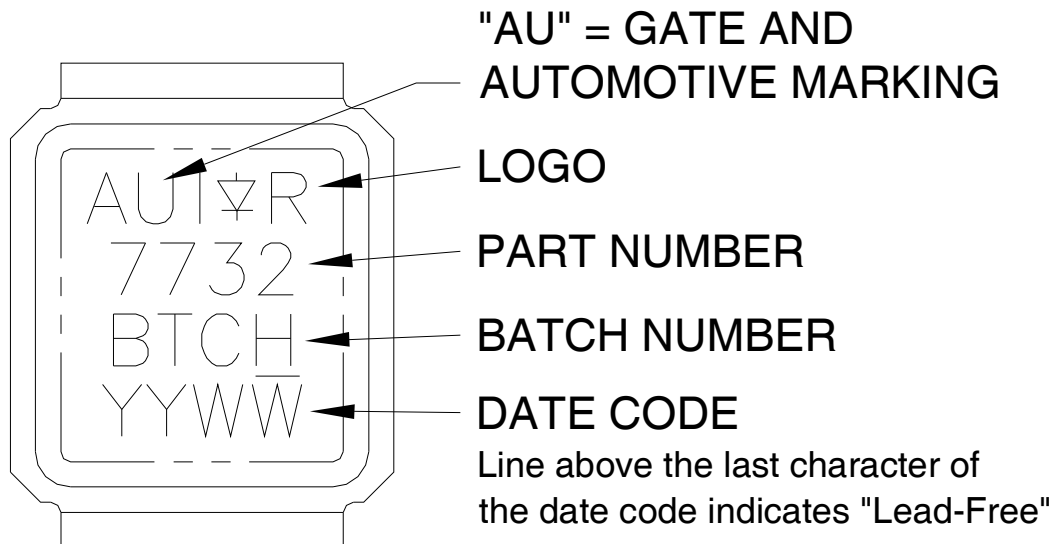
**Automotive DirectFET® Outline Dimension, SC Outline (Small Size Can).**

Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations

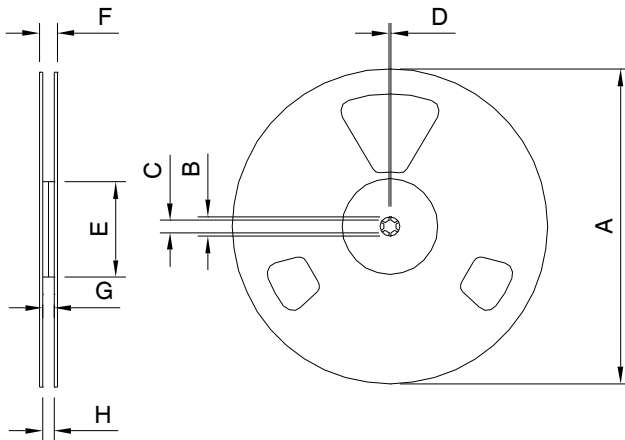


CODE	METRIC		IMPERIAL	
	MIN	MAX	MIN	MAX
A	4.75	4.85	0.187	0.191
B	3.70	3.95	0.146	0.156
C	2.75	2.85	0.108	0.112
D	0.35	0.45	0.014	0.018
E	0.58	0.62	0.023	0.024
F	0.78	0.82	0.031	0.032
G	0.75	0.80	0.030	0.031
H	0.63	0.67	0.025	0.026
J	0.38	0.42	0.015	0.016
K	0.95	1.05	0.037	0.041
L	2.15	2.25	0.085	0.088
M	0.68	0.74	0.027	0.029
P	0.08	0.17	0.003	0.007
R	0.02	0.08	0.001	0.003

Dimensions are shown in millimeters (inches)

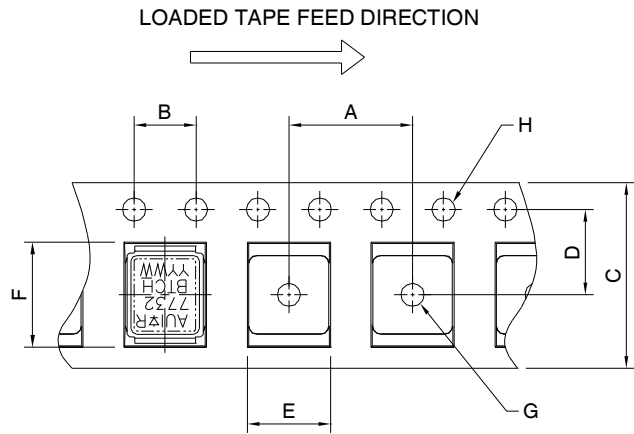
**Automotive DirectFET® Part Marking**

 Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

### Automotive DirectFET<sup>®</sup> Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm  
Std reel quantity is 4800 parts. (ordered as AUIRF7732S2TR). For 1000 parts on 7" reel, order AUIRF7732S2TR1

REEL DIMENSIONS								
STANDARD OPTION (QTY 4800)					TR1 OPTION (QTY 1000)			
CODE	METRIC		IMPERIAL		METRIC		IMPERIAL	
A	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C
B	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C
C	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C
E	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C
H	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C



NOTE: CONTROLLING DIMENSIONS IN MM

CODE	DIMENSIONS			
	METRIC		IMPERIAL	
	MIN	MAX	MIN	MAX
A	7.90	8.10	0.311	0.319
B	3.90	4.10	0.154	0.161
C	11.90	12.30	0.469	0.484
D	5.45	5.55	0.215	0.219
E	4.00	4.20	0.158	0.165
F	5.00	5.20	0.197	0.205
G	1.50	N.C	0.059	N.C
H	1.50	1.60	0.059	0.063

Notes:

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④  $T_C$  measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.

- ⑥ Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.083\text{mH}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 33\text{A}$ ,  $V_{GS} = 20\text{V}$ .
- ⑦ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑧ Used double sided cooling, mounting pad with large heatsink.
- ⑨ Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- ⑩  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .

**Qualification Information<sup>†</sup>**

<b>Qualification Level</b>		Automotive (per AEC-Q101) <sup>††</sup>	
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
<b>Moisture Sensitivity Level</b>		SMALL-CAN	MSL1, 260°C
<b>ESD</b>	Machine Model	Class M2 (+/- 200V) <sup>†††</sup> AEC-Q101-002	
	Human Body Model	Class H1B (+/- 1000V) <sup>†††</sup> AEC-Q101-001	
	Charged Device Model	N/A AEC-Q101-005	
<b>RoHS Compliant</b>		Yes	

† Qualification standards can be found at International Rectifier's web site: <http://www.irf.com>

†† Exceptions to AEC-Q101 requirements are noted in the qualification report.

††† Highest passing voltage.

## IMPORTANT NOTICE

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For technical support, please contact IR's Technical Assistance Center

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